

# STV240N75F3

## N-channel 75 V - 2.3 mΩ - 240 A - PowerSO-10 STripFET™ Power MOSFET

Preliminary Data

### Features

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STV240N75F3	75 V	< 2.6 mΩ	240 A

- Conduction losses reduced
- Low profile, very low parasitic inductance

### Application

Switching applications

### Description

This n-channel enhancement mode Power MOSFET is the latest refinement of STMicroelectronics unique "single feature size" strip-based process with less critical alignment steps and therefore a remarkable manufacturing reproducibility. The resulting transistor shows extremely high packing density for low onresistance, rugged avalanche characteristics and low gate charge.



# Figure 1. Internal schematic diagram and connection diagram (top view)



#### Table 1. Device summary

Order code	Marking	Package	Packaging
STV240N75F3	240N75F3	PowerSO-10	Tape and reel

April 2008

## 1 Electrical ratings

Table 2.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage ( $V_{GS} = 0$ )	75	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
Ι <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	240	Α
Ι <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	170	A
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	960	A
P <sub>TOT</sub> <sup>(2)</sup>	Total dissipation at $T_{C} = 25 \ ^{\circ}C$	300	w
	Derating factor	2.0	W/°C
E <sub>AS</sub> <sup>(3)</sup>	Single pulse avalanche energy	600	mJ
T <sub>stg</sub>	Storage temperature	-55 to 175	°C
Тj	Operating junction temperature	175	°C

1. Pulse width limited by safe operating area

2. This value is rated according to Rthj-c

3. Starting Tj = 25 °C,  $I_D$  = 60 A,  $V_{DD}$  = 15 V

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.5	°C/W
${\sf R}_{thj\text{-pcb}}^{}^{(1)}$	Thermal resistance junction-pcb max	50	°C/W

1. When mounted on 1 inch<sup>2</sup> FR-4 2 oz Cu.



## 2 Electrical characteristics

(T<sub>CASE</sub> =25 °C unless otherwise specified)

	0					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0$	75			V
I <sub>DSS</sub>	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS}$ = Max rating, $V_{DS}$ = Max rating, T <sub>C</sub> = 125 °C			10 100	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>DS</sub> = ± 20 V			±200	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	2		4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 120 A		2.3	2.6	mΩ

#### Table 4. On /off states

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> =0		6800 1100 50		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	V <sub>DD</sub> = 60 V, I <sub>D</sub> = 120 A, V <sub>GS</sub> = 10 V <i>(see Figure 3)</i>		100 30 30		nC nC nC



Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD} = 37.5 \text{ V}, I_D = 60 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V},$ <i>(see Figure 2)</i>		25 70		ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off delay time Fall time	$V_{DD} = 37.5 \text{ V}, I_D = 60 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V},$ <i>(see Figure 2)</i>		100 15		ns ns

Table 6.Switching times

 Table 7.
 Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SD</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)				240 960	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 120 A, V <sub>GS</sub> = 0			1.5	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 120 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 30 \text{ V}, \text{ T}_{j} = 150 ^{\circ}\text{C}$ (see Figure 7)		70 150 4.2		ns nC A

1. Pulse width limited by safe operating area

2. Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%



## 3 Test circuits

Figure 2. Switching times test circuit for resistive load





**Unclamped inductive load test** 

Figure 4. Test circuit for inductive load switching and diode recovery times







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circuit

 $V_{\text{D}}$ 

Figure 7. Switching time waveform



Figure 5.

Figure 3. Gate charge test circuit

V<sub>DD</sub>

### Figure 8. Gate charge test waveform

### Figure 9. Diode recovery times waveform





### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com* 



DIM.		mm			inch	
DIN.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	3.35		3.65	0.132		0.144
A1	0.00		0.10	0.000		0.004
В	0.40		0.60	0.016		0.024
С	0.35		0.55	0.013		0.022
D	9.40		9.60	0.370		0.378
D1	7.40		7.60	0.291		0.300
е		1.27			0.050	
E	9.30		9.50	0.366		0.374
E1	7.20		7.40	0.283		0.291
E2	7.20		7.60	0.283		0.300
E3	6.10		6.35	0.240		0.250
E4	5.90		6.10	0.232		0.240
F	1.25		1.35	0.049		0.053
h		0.50			0.002	
Н	13.80		14.40	0.543		0.567
L	1.20		1.80	0.047		0.071
q		1.70			0.067	
α	0°		8°			

#### PowerSO-10 MECHANICAL DATA





## 5 Revision history

#### Table 8.Document revision history

Date	Revision	Changes
02-Apr-2008	1	Initial release



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